

## Advanced Power MOSFET

## IRFS624A

### FEATURES

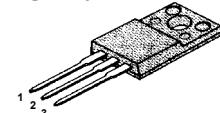
- Avalanche Rugged Technology
- Rugged Gate Oxide Technology
- Lower Input Capacitance
- Improved Gate Charge
- Extended Safe Operating Area
- Lower Leakage Current : 10  $\mu$ A (Max.) @  $V_{DS} = 250V$
- Low  $R_{DS(on)}$  : 0.742  $\Omega$  (Typ.)

$BV_{DSS} = 250 V$

$R_{DS(on)} = 1.1 \Omega$

$I_D = 3.4 A$

TO-220F



1.Gate 2. Drain 3. Source

### Absolute Maximum Ratings

Symbol	Characteristic	Value	Units
$V_{DSS}$	Drain-to-Source Voltage	250	V
$I_D$	Continuous Drain Current ( $T_C=25^\circ C$ )	3.4	A
	Continuous Drain Current ( $T_C=100^\circ C$ )	2.1	
$I_{DM}$	Drain Current-Pulsed	16	A
$V_{GS}$	Gate-to-Source Voltage	$\pm 30$	V
$E_{AS}$	Single Pulsed Avalanche Energy	72	mJ
$I_{AR}$	Avalanche Current	3.4	A
$E_{AR}$	Repetitive Avalanche Energy	3.4	mJ
$dv/dt$	Peak Diode Recovery $dv/dt$	4.8	V/ns
$P_D$	Total Power Dissipation ( $T_C=25^\circ C$ )	34	W
	Linear Derating Factor	0.27	$W/\text{ }^\circ C$
$T_J, T_{STG}$	Operating Junction and Storage Temperature Range	- 55 to +150	$^\circ C$
	Maximum Lead Temp. for Soldering Purposes, 1/8 " from case for 5-seconds	300	

### Thermal Resistance

Symbol	Characteristic	Typ.	Max.	Units
$R_{\theta JC}$	Junction-to-Case	--	3.7	$^\circ C/W$
$R_{\theta JA}$	Junction-to-Ambient	--	62.5	

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## Electrical Characteristics ( $T_C=25^\circ\text{C}$ unless otherwise specified)

Symbol	Characteristic	Min.	Typ.	Max.	Units	Test Condition
$\text{BV}_{\text{DSS}}$	Drain-Source Breakdown Voltage	250	--	--	V	$\text{V}_{\text{GS}}=0\text{V}, \text{I}_D=250\text{ }\mu\text{A}$
$\Delta \text{BV}/\Delta T_J$	Breakdown Voltage Temp. Coeff.	--	0.30	--	V/°C	$\text{I}_D=250\text{ }\mu\text{A}$ See Fig 7
$\text{V}_{\text{GS}(\text{th})}$	Gate Threshold Voltage	2.0	--	4.0	V	$\text{V}_{\text{DS}}=5\text{V}, \text{I}_D=250\text{ }\mu\text{A}$
$\text{I}_{\text{GSS}}$	Gate-Source Leakage , Forward	--	--	100	nA	$\text{V}_{\text{GS}}=30\text{V}$
	Gate-Source Leakage , Reverse	--	--	-100		$\text{V}_{\text{GS}}=-30\text{V}$
$\text{I}_{\text{DSS}}$	Drain-to-Source Leakage Current	--	--	10	$\mu\text{A}$	$\text{V}_{\text{DS}}=250\text{V}$
		--	--	100		$\text{V}_{\text{DS}}=200\text{V}, \text{T}_C=125^\circ\text{C}$
$\text{R}_{\text{DS}(\text{on})}$	Static Drain-Source On-State Resistance	--	--	1.1	Ω	$\text{V}_{\text{GS}}=10\text{V}, \text{I}_D=1.7\text{A}$ ④
$\text{g}_{\text{fs}}$	Forward Transconductance	--	2.47	--	Ω	$\text{V}_{\text{DS}}=40\text{V}, \text{I}_D=1.7\text{A}$ ④
$\text{C}_{\text{iss}}$	Input Capacitance	--	335	430	pF	$\text{V}_{\text{GS}}=0\text{V}, \text{V}_{\text{DS}}=25\text{V}, f=1\text{MHz}$ See Fig 5
$\text{C}_{\text{oss}}$	Output Capacitance	--	55	65		
$\text{C}_{\text{rss}}$	Reverse Transfer Capacitance	--	23	28		
$t_{\text{d}(\text{on})}$	Turn-On Delay Time	--	11	30	ns	$\text{V}_{\text{DD}}=125\text{V}, \text{I}_D=4.1\text{A}, \text{R}_G=18\text{ }\Omega$ See Fig 13 ④ ⑤
$t_r$	Rise Time	--	12	35		
$t_{\text{d}(\text{off})}$	Turn-Off Delay Time	--	32	75		
$t_f$	Fall Time	--	15	40		
$\text{Q}_g$	Total Gate Charge	--	14	20	nC	$\text{V}_{\text{DS}}=200\text{V}, \text{V}_{\text{GS}}=10\text{V}, \text{I}_D=4.1\text{A}$
$\text{Q}_{\text{gs}}$	Gate-Source Charge	--	2.8	--		See Fig 6 & Fig 12 ④ ⑤
$\text{Q}_{\text{gd}}$	Gate-Drain("Miller") Charge	--	6.4	--		

## Source-Drain Diode Ratings and Characteristics

Symbol	Characteristic	Min.	Typ.	Max.	Units	Test Condition
$\text{I}_S$	Continuous Source Current	--	--	3.4	A	Integral reverse pn-diode in the MOSFET
$\text{I}_{\text{SM}}$	Pulsed-Source Current ①	--	--	16		
$\text{V}_{\text{SD}}$	Diode Forward Voltage ④	--	--	1.5	V	$\text{T}_J=25^\circ\text{C}, \text{I}_S=3.4\text{A}, \text{V}_{\text{GS}}=0\text{V}$
$\text{t}_{\text{rr}}$	Reverse Recovery Time	--	135	--	ns	$\text{T}_J=25^\circ\text{C}, \text{I}_F=4.1\text{A}$ $d\text{I}/dt=100\text{A}/\mu\text{s}$ ④
$\text{Q}_{\text{rr}}$	Reverse Recovery Charge	--	0.65	--	μC	

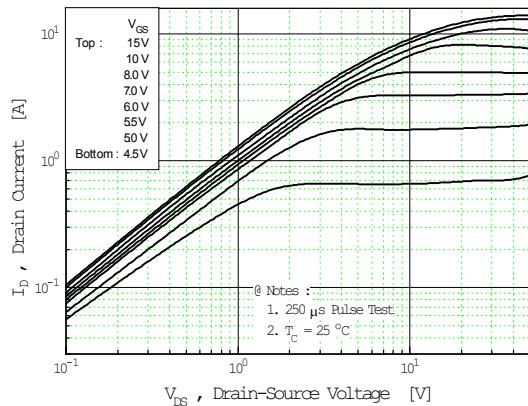
### Notes :

- ① Repetitive Rating : Pulse Width Limited by Maximum Junction Temperature
- ②  $L=10\text{mH}, \text{I}_{AS}=3.4\text{A}, \text{V}_{DD}=50\text{V}, \text{R}_G=27\Omega, \text{Starting } T_J=25^\circ\text{C}$
- ③  $\text{I}_{SD} \leq 4.1\text{A}, d\text{I}/dt \leq 170\text{A}/\mu\text{s}, \text{V}_{DD} \leq \text{BV}_{DSS}$ , Starting  $T_J=25^\circ\text{C}$
- ④ Pulse Test : Pulse Width =  $250\mu\text{s}$ , Duty Cycle  $\leq 2\%$
- ⑤ Essentially Independent of Operating Temperature

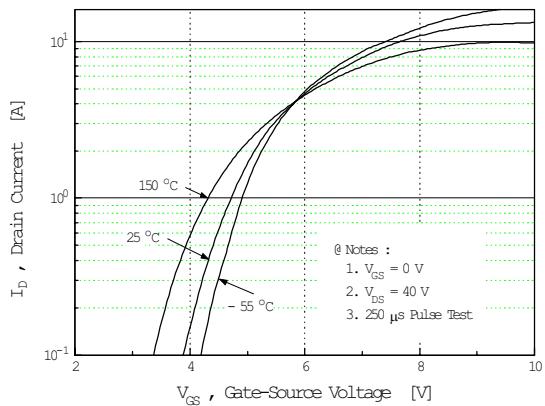
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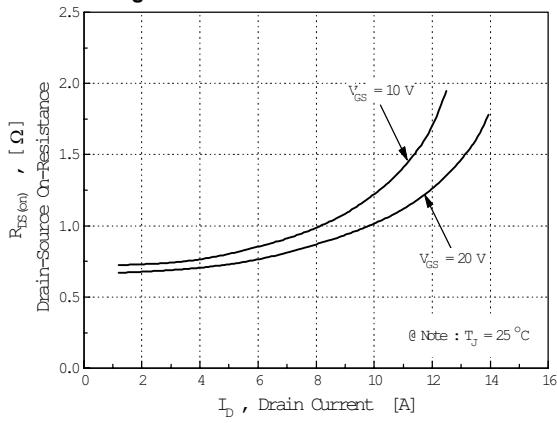
**Fig 1. Output Characteristics**



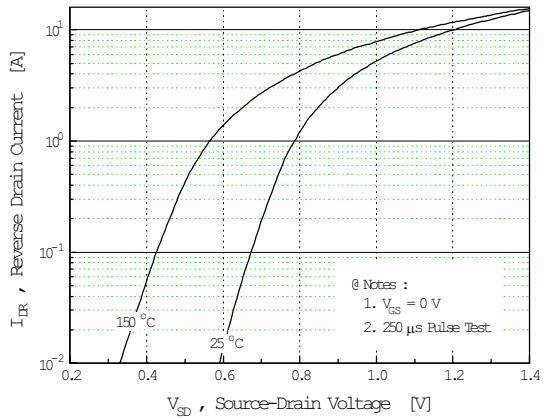
**Fig 2. Transfer Characteristics**



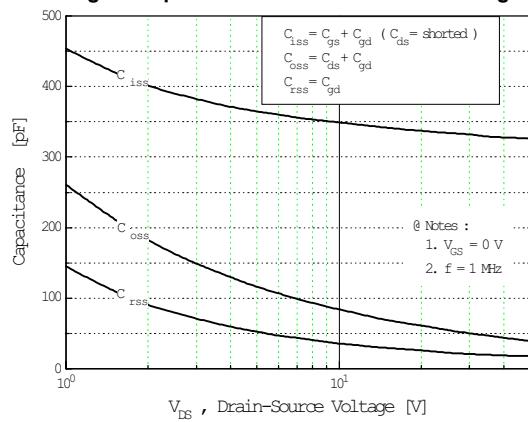
**Fig 3. On-Resistance vs. Drain Current**



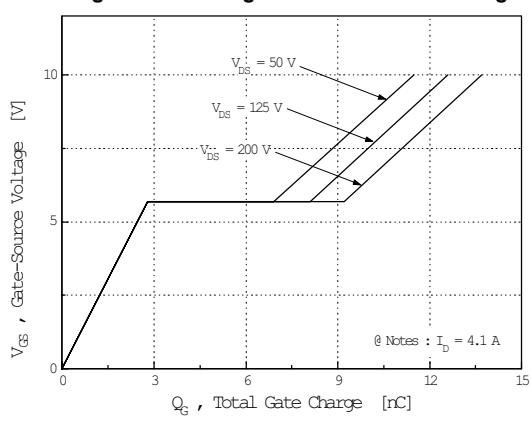
**Fig 4. Source-Drain Diode Forward Voltage**



**Fig 5. Capacitance vs. Drain-Source Voltage**



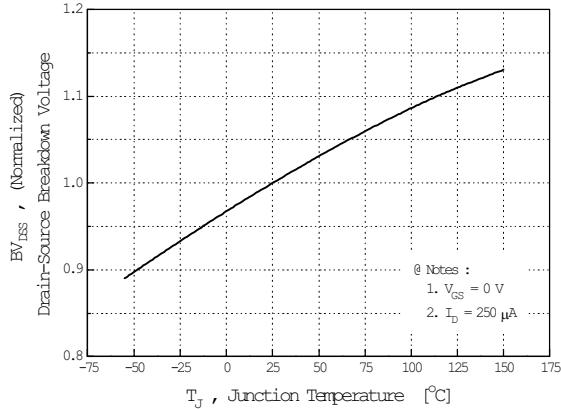
**Fig 6. Gate Charge vs. Gate-Source Voltage**



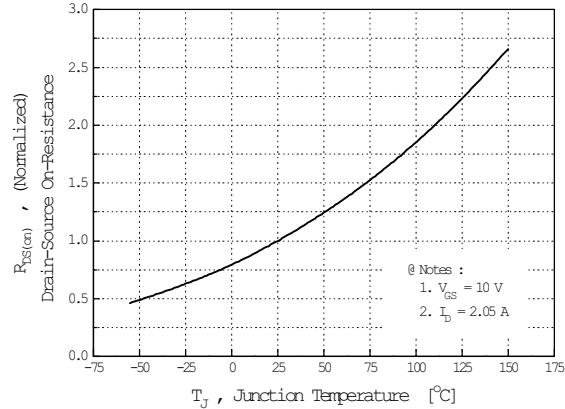
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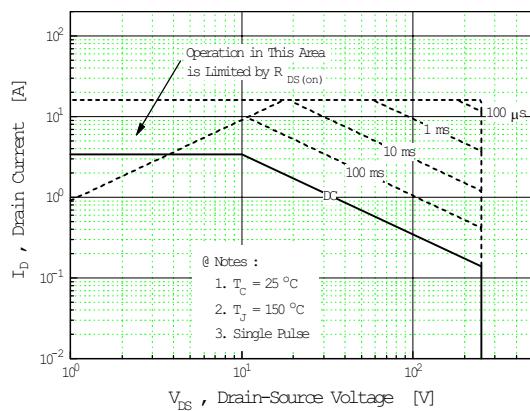
**Fig 7. Breakdown Voltage vs. Temperature**



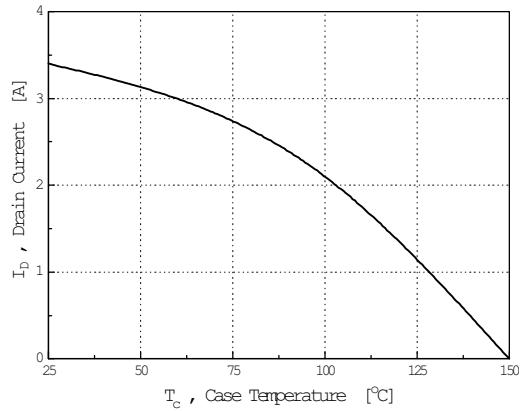
**Fig 8. On-Resistance vs. Temperature**



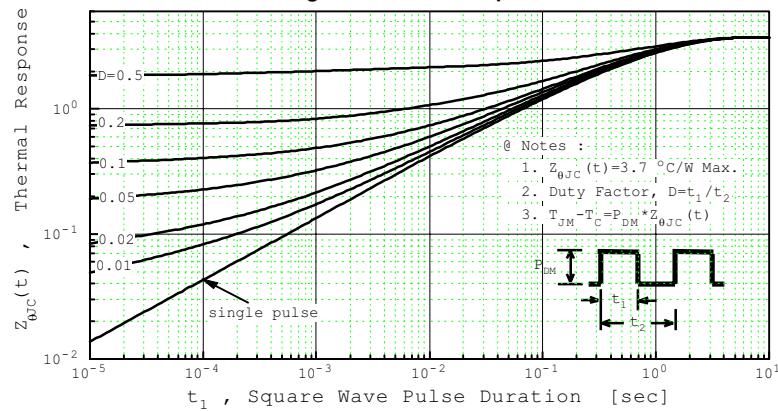
**Fig 9. Max. Safe Operating Area**



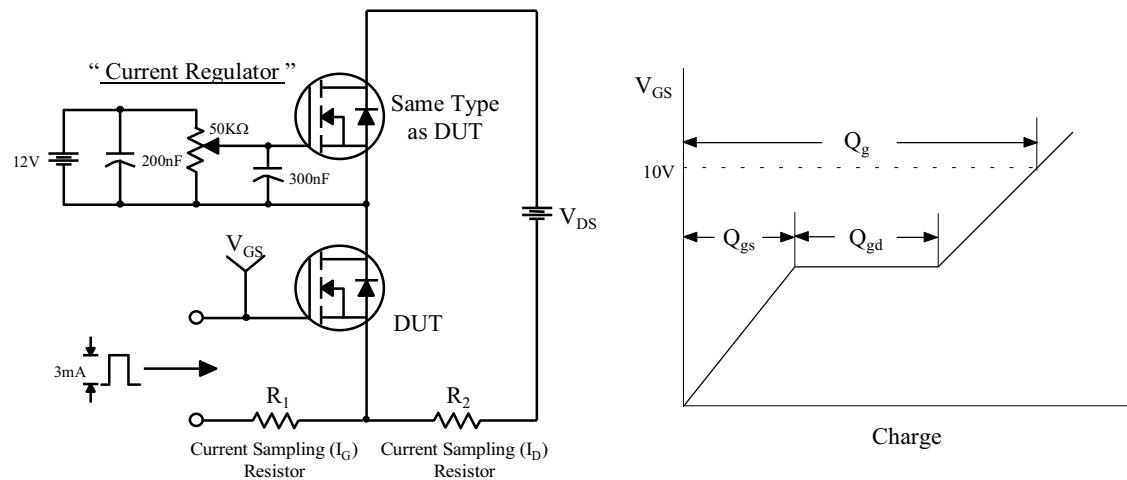
**Fig 10. Max. Drain Current vs. Case Temperature**



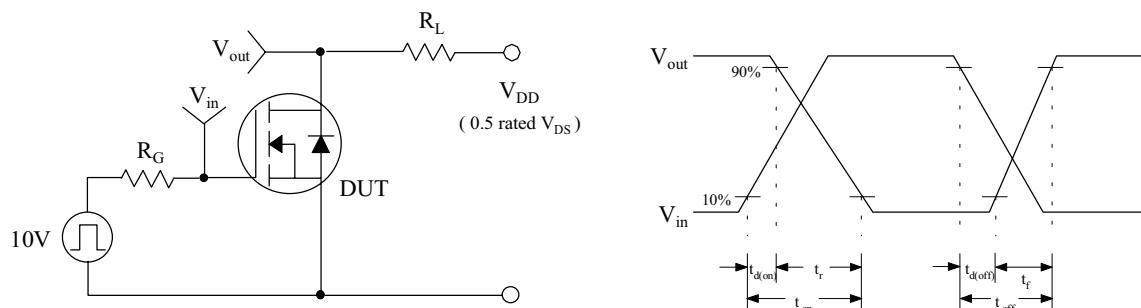
**Fig 11. Thermal Response**



**Fig 12. Gate Charge Test Circuit & Waveform**



**Fig 13. Resistive Switching Test Circuit & Waveforms**



**Fig 14. Unclamped Inductive Switching Test Circuit & Waveforms**



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Fig 15. Peak Diode Recovery dv/dt Test Circuit & Waveforms

